

PROTECTION PRODUCTS

Description

EClamp®2367NQ integrates low capacitance ESD protection, low pass filters, and pull up resistors designed specifically for secure digital card interfaces in automotive applications. It is compliant with SD3.01 UHS-1 SDR 104 standard.

EClamp2367NQ is an easily implemented solution for replacing discrete resistors and ESD protection devices in a single package. These devices utilize silicon avalanche technology for superior ESD and TLP clamping performance. They feature maximum ESD withstand voltage of $\pm 12\text{kV}$ contact, $\pm 15\text{kV}$ air discharge per IEC 61000-4-2. They are qualified to AEC-Q100 for use in automotive applications.

EClamp2367NQ is in a SLP3030P16 package, measuring 3.0 x 3.0mm with a nominal height of 0.60mm. The leads have a nominal pin-to-pin pitch of 0.50mm.

Features

- Transient Protection to
 - ♦ IEC 61000-4-2 (ESD): 15kV (Air), 12kV (Contact)
 - ♦ IEC 61000-4-4 (EFT) 4kV (5/50ns)
 - ♦ ISO-10605 (ESD): 15kV (Air), 12kV (Contact)
- Qualified to AEC-Q100, Grade 1
- Compliant with SD3.01 UHS-1 SDR 104 Standard
- Low capacitance to accommodate long PCB traces
- Low ESD Clamping Voltage
- Solid-State Silicon-Avalanche Technology

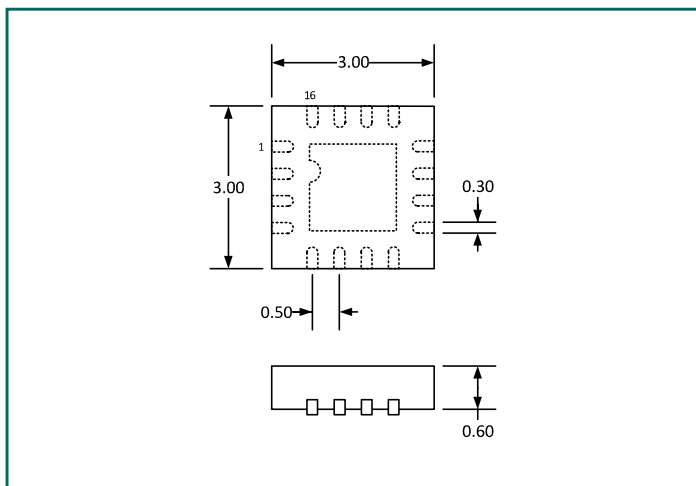
Mechanical Characteristics

- SLP3030P16 package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: 3.0 x 3.0 x 0.6 mm
- Lead Finish: NiPdAu
- Molding Compound Flammability Rating: UL 94V-0
- Marking : Marking Code + Date Code
- Packaging : Tape and Reel

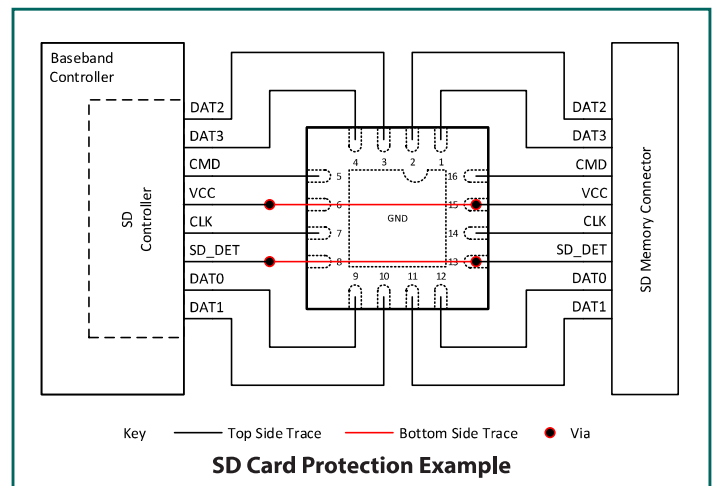
Applications

- Automotive Applications
- Secure Digital (SD) Memory Card Interfaces
- Multimedia Card Interfaces (MCI)

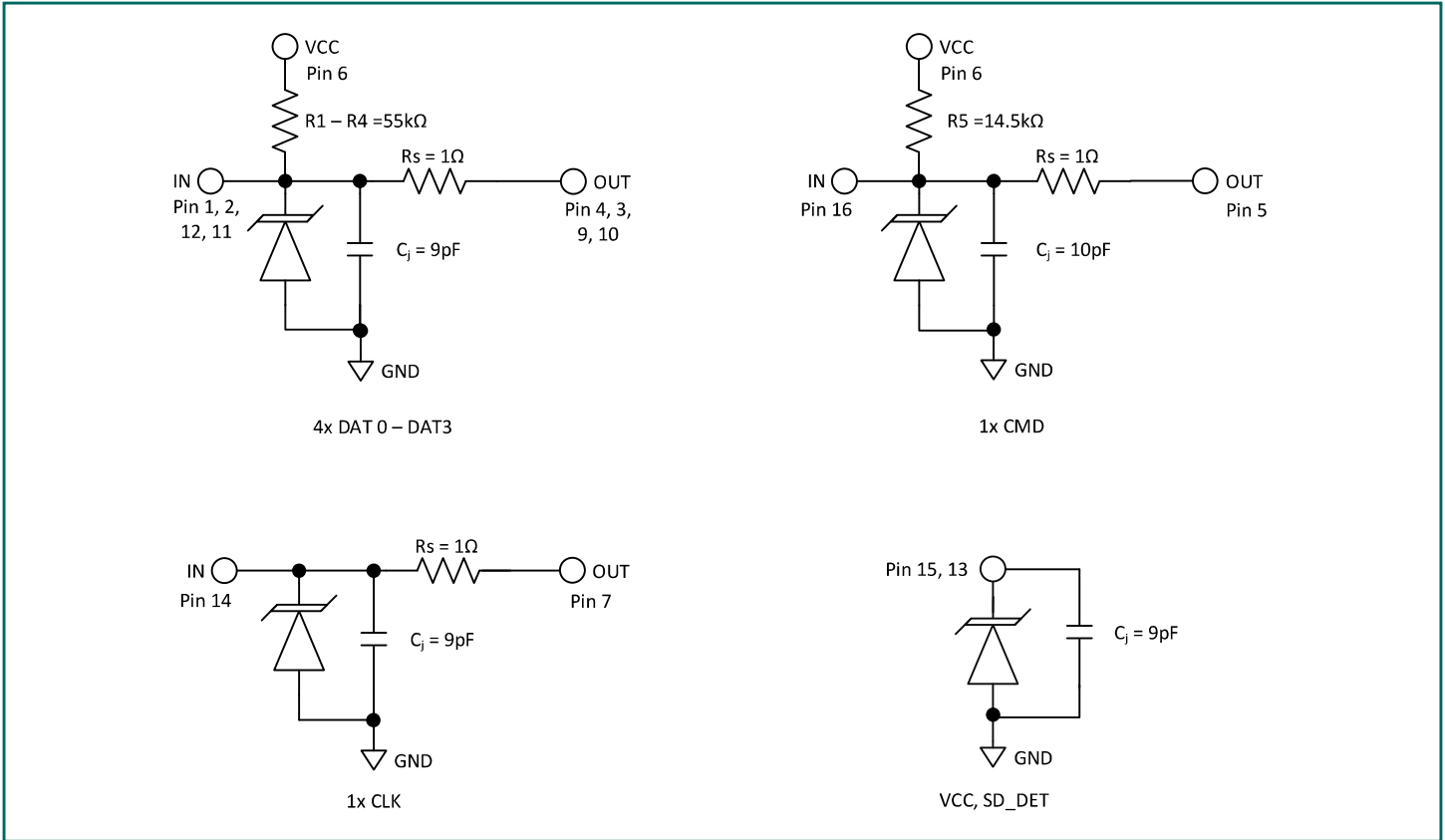
Nominal Dimensions



Application Diagram



Schematic and Pin Identification



Note:
All values are typical and measured at T = 25°C

Absolute Maximum Ratings

Rating	Symbol	Value	Units
ESD per IEC 61000-4-2 (Contact) ⁽¹⁾ ESD per IEC 61000-4-2 (Air) ⁽¹⁾	V_{ESD}	± 12 ± 15	kV
ESD per ISO-10605 (Contact) ⁽²⁾ ESD per ISO-10605 (Air) ⁽²⁾	V_{ESD}	± 12 ± 15	kV
Operating Temperature	T_{OP}	-40 to +125	°C
Storage Temperature	T_{STG}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

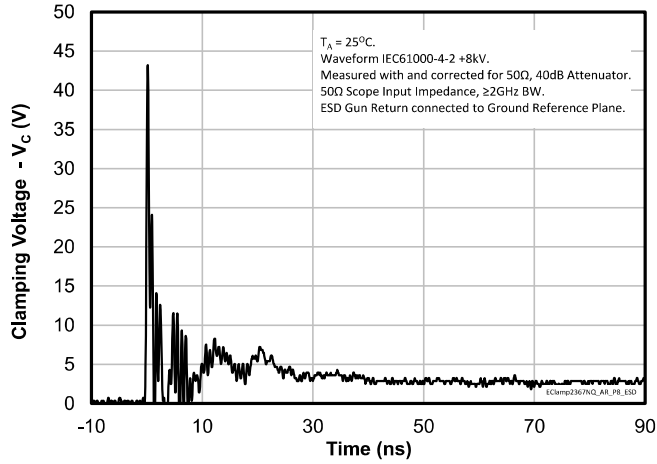
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Units	
Reverse Stand-Off Voltage	V_{RWM}	-40°C to 125°C, Any I/O Pin to GND Tab			5	V	
Reverse Breakdown Voltage	V_{BR}	$I_t = 1\text{mA}$, Any I/O Pin to GND Tab	-40°C to 125°C	6	7.5	10	V
Reverse Leakage Current	I_R	$V_{RWM} = 5\text{V}$ Any I/O Pin to GND Tab	T = 25°C		0.01	0.100	μA
			T = 125°C		0.06	0.200	μA
ESD Clamping Voltage ⁽³⁾	V_C	$I_{PP} = 4\text{A}$, $t_p = 0.2/100\text{ns}$ (TLP)		10		V	
	V_C	$I_{PP} = 16\text{A}$, $t_p = 0.2/100\text{ns}$ (TLP)		15.5		V	
Capacitance	C_j	Pin1, 2, 3, 4, 7, 9, 10, 11, 12, 13, 14, or 15 to GND	$V_R = 0\text{V}$, $f = 1\text{MHz}$		9	11	pF
		Pin 5 or 16 to GND			10	12	
Pull-Up Resistors (DAT0 - DAT3)	R_1, R_2, R_3, R_4	Pins 1, 2, 11, 12 to Pin 6	40	55	60	kΩ	
Pull-Up Resistor (CMD)	R_5	Pin 16 to Pin 6	12	14.5	18		
Series Resistors	R_S	-40°C to 125°C	0.5	1	2	Ω	

Notes:

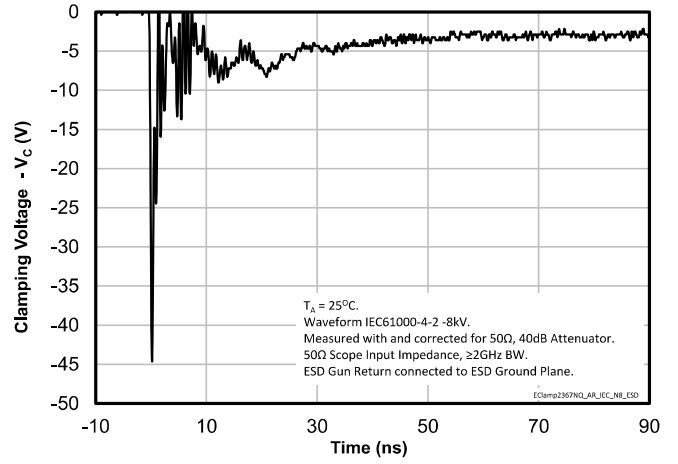
- (1): ESD Gun return path to Ground Reference Plane (GRP)
- (2): ESD Gun return path to Horizontal Coupling Plane (HCP); Test conditions: a) 150pF/330pF, 330Ω
- (3): Transmission Line Pulse Test (TLP) Settings: $t_p = 100\text{ns}$, $t_r = 0.2\text{ns}$, I_{TLP} and V_{TLP} averaging window: $t_1 = 70\text{ns}$ to $t_2 = 90\text{ns}$
- (4): Dynamic resistance calculated from $I_{TLP} = 4\text{A}$ to $I_{TLP} = 16\text{A}$

Typical Characteristics

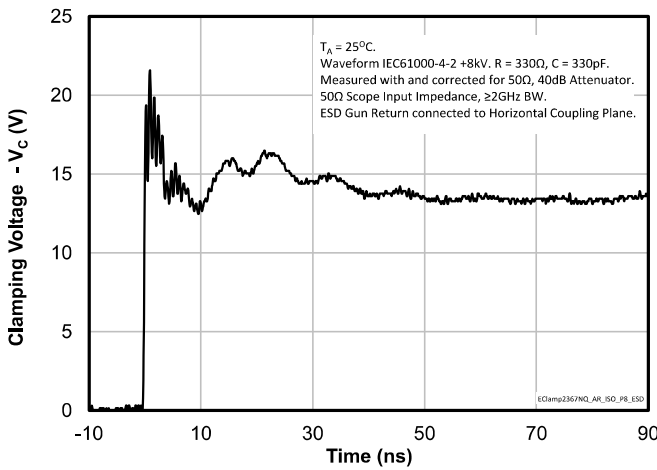
ESD Clamping (+8kV Contact per IEC 61000-4-2)



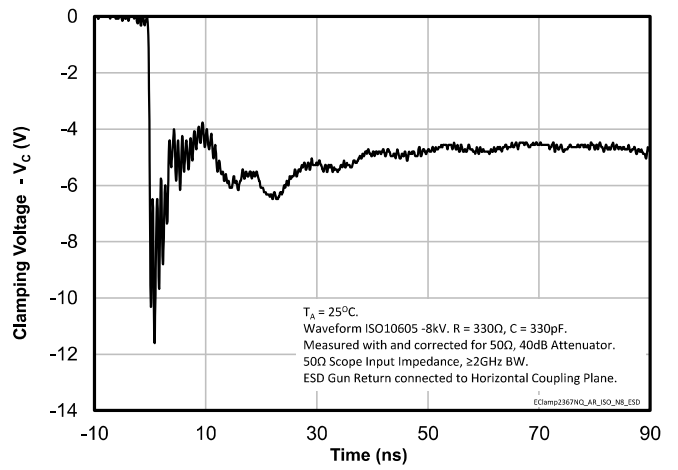
ESD Clamping (-8kV Contact per IEC 61000-4-2)



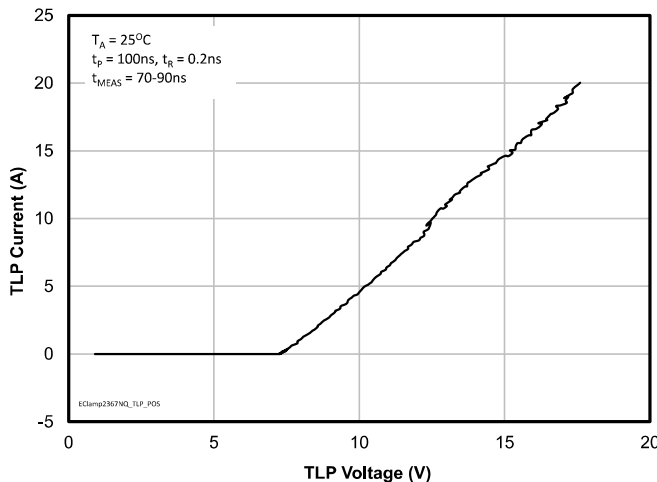
ESD Clamping (+8kV Contact per ISO-10605 330pF, 330Ω)



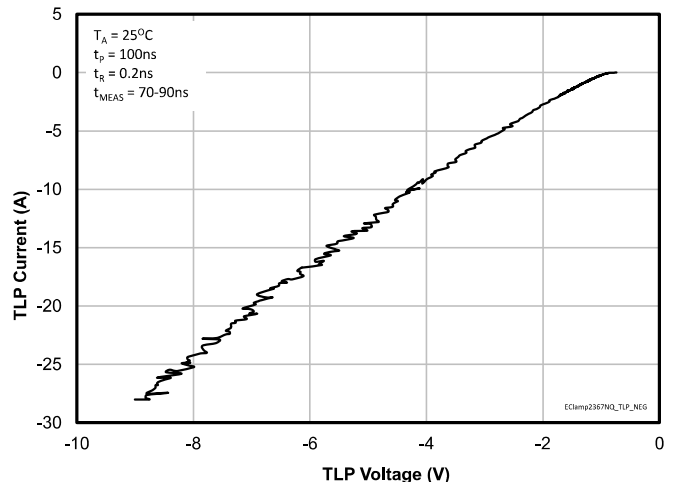
ESD Clamping (-8kV Contact per ISO-10605 330pF, 330Ω)



TLP Characteristic (Any Pin to GND)

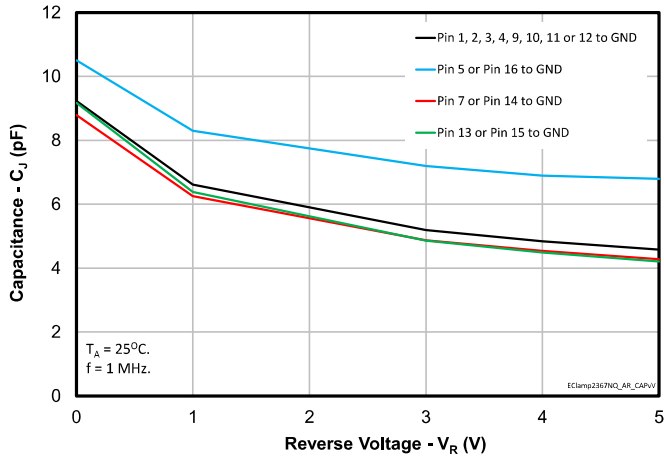


TLP Characteristic (GND to Any Pin)

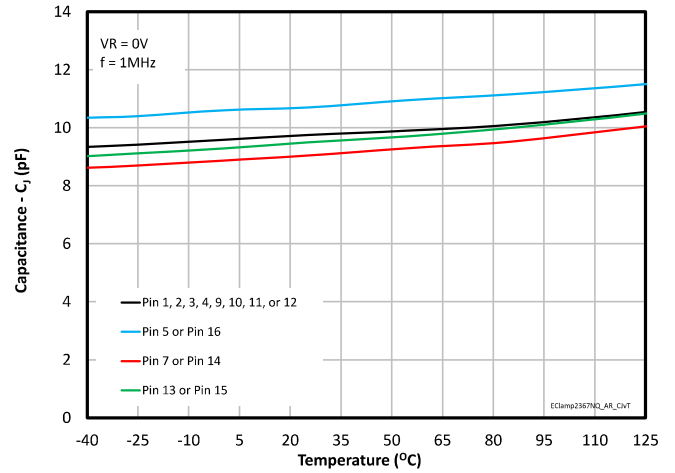


Typical Characteristics

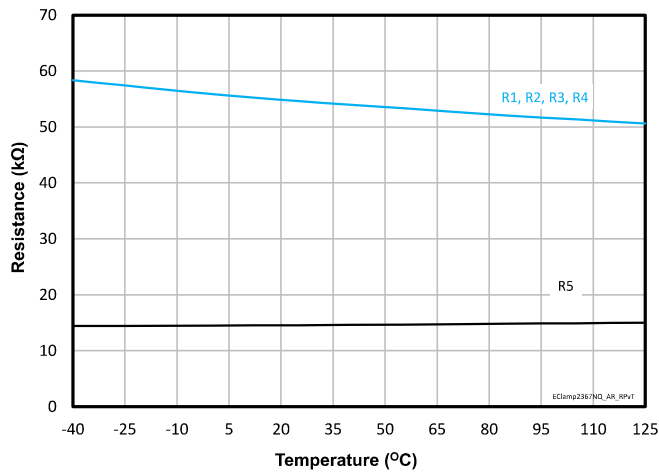
Junction Capacitance (Line to GND) vs. Reverse Voltage



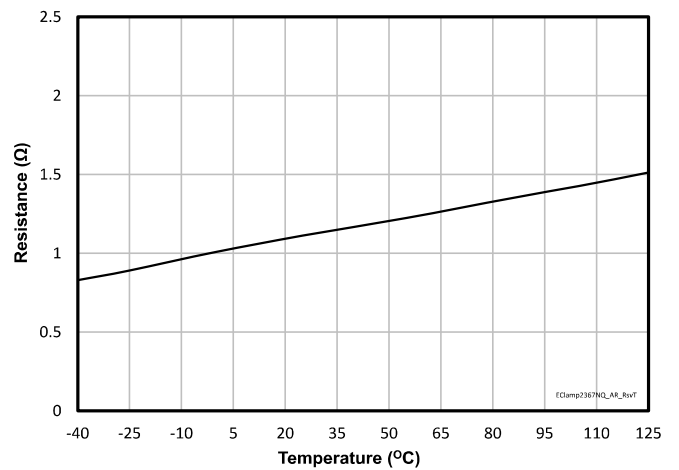
Junction Capacitance to GND vs. Temperature



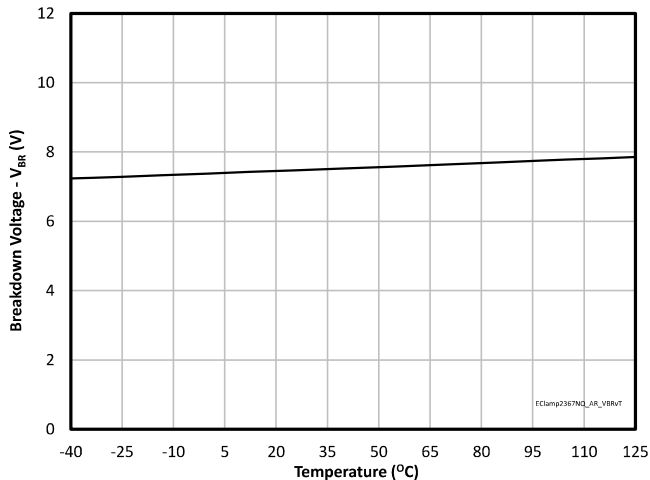
Resistance (Pull up Resistors) vs. Temperature



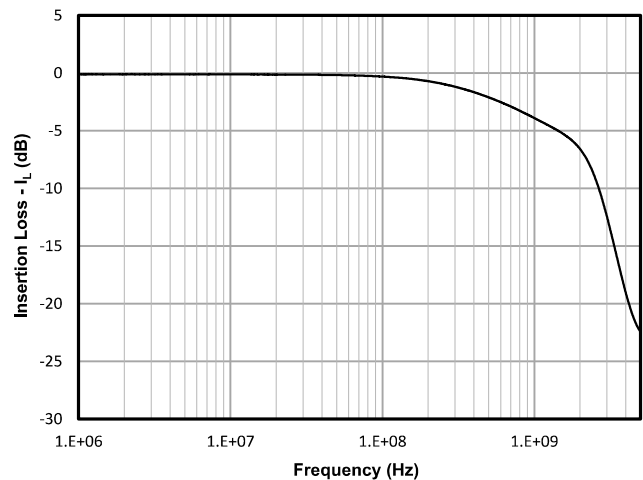
Resistance (Series Resistors) vs. Temperature



Breakdown Voltage (V_{BR}) vs. Temperature



Insertion Loss (S21)



Application Information

Secure Digital Interface Protection

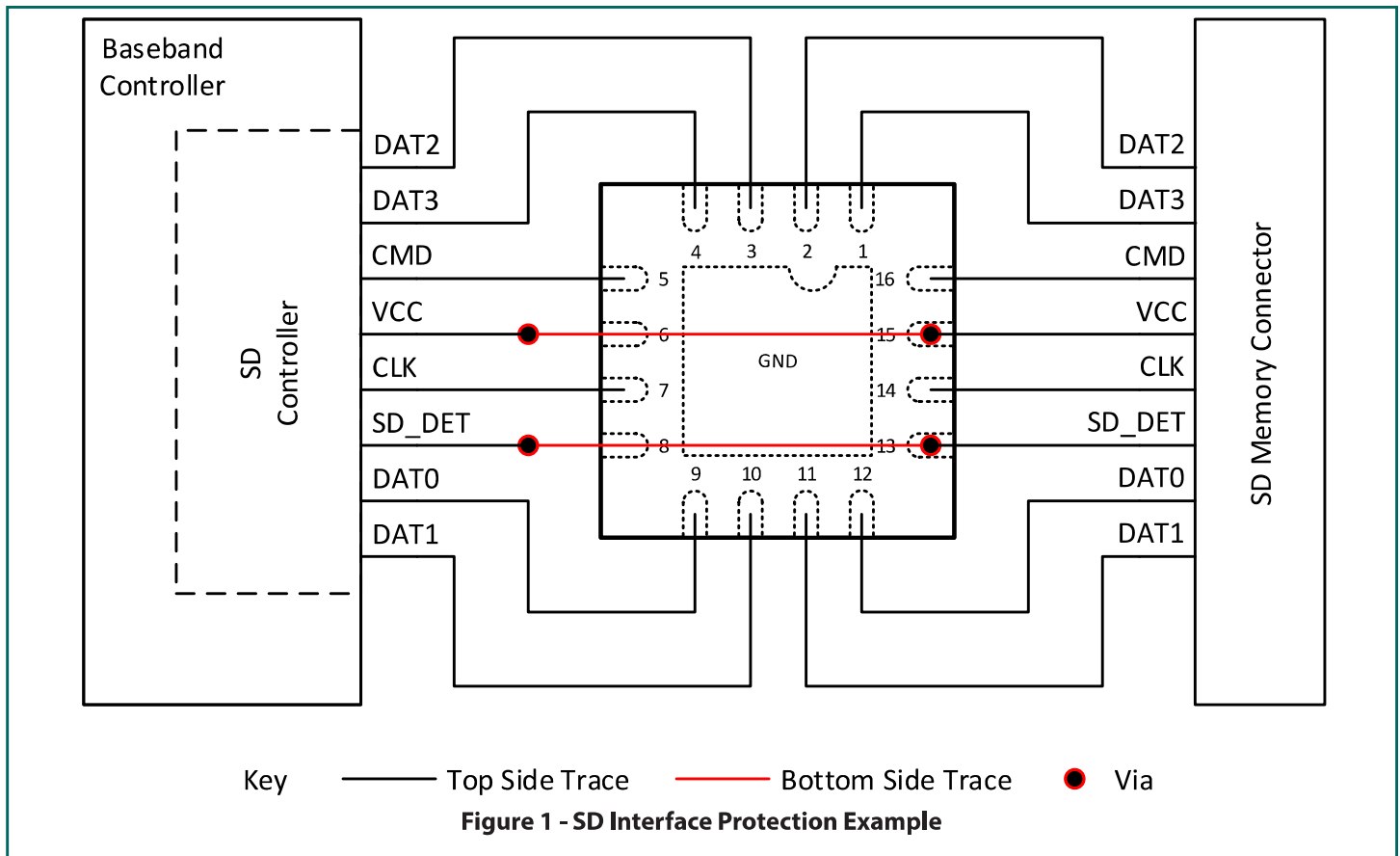
EClamp2367NQ is specifically designed for secure digital card interfaces in automotive applications. It is compliant with SD3.01 UHS-1 SDR 104 standard. Each device integrates TVS diodes, series resistors, and bus pull up resistors. The device has been tested and qualified to AEC-Q100, Grade 1 for use in automotive applications.

Device Connection

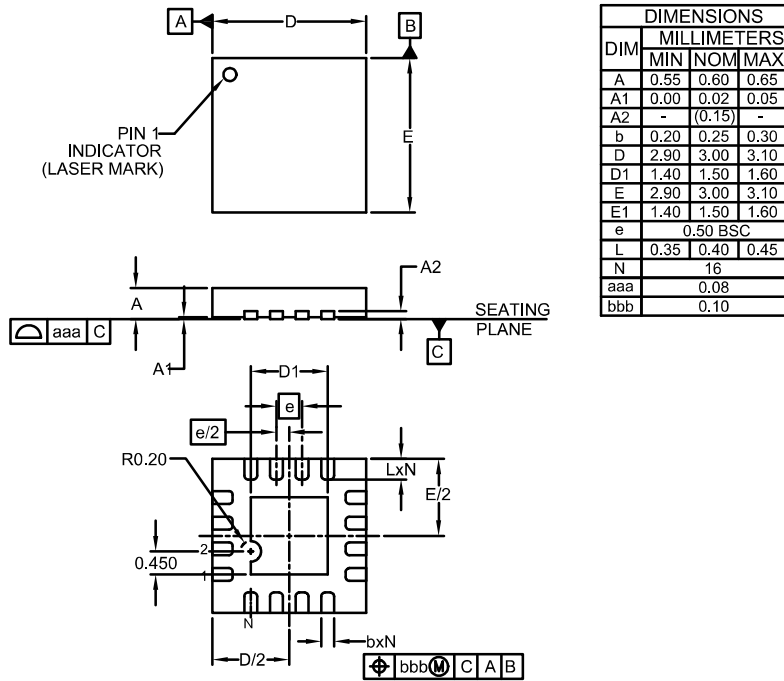
A typical application circuit is shown below. Since the device contains series resistors, lines enter and exit separate pins as shown. The center tab serves as the ground connection. As such, connection to the VCC pins (and SD_DET if used) requires vias to a different board layer. All other connections can be made on the same layer where the device is located.

Device Placement

Placement of the protection component is a critical element for effective ESD suppression. EClamp2367NQ should be placed as close to the connector as possible. Ground connection should be made directly to the ground plane using micro-vias. This reduces parasitic inductance in the ground path and minimizes the clamping voltage seen by the protected device.



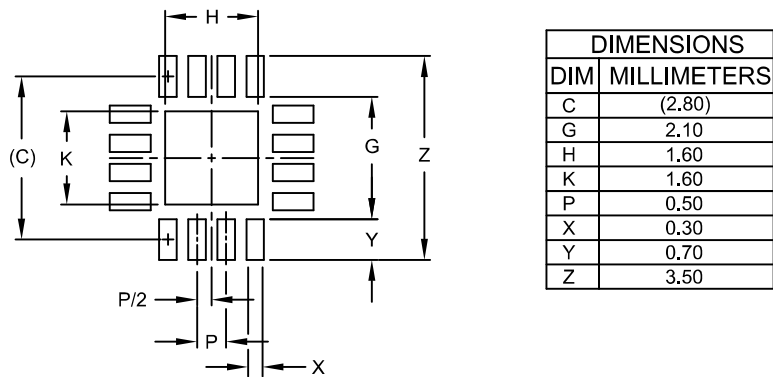
Outline Drawing - SLP3030P16



NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
2. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

Land Pattern - SLP3030P16



NOTES:

1. THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY. CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR COMPANY'S MANUFACTURING GUIDELINES ARE MET.
2. DO NOT PLACE VIAS BETWEEN THE CORNER LEADS INSIDE THE 3X3MM PACKAGE FOOTPRINT.
3. THERMAL VIAS IN THE LAND PATTERN OF THE EXPOSED PAD SHALL BE CONNECTED TO A SYSTEM GROUND PLANE. FAILURE TO DO SO MAY COMPROMISE THE THERMAL AND/OR FUNCTIONAL PERFORMANCE OF THE DEVICE.



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